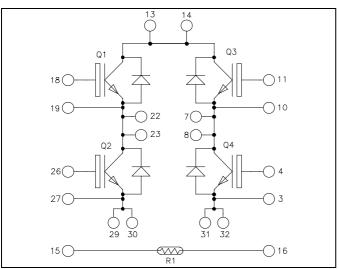
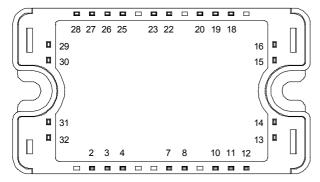


Full - Bridge NPT IGBT Power Module

 $V_{CES} = 1200V$ $I_{C} = 25A @ Tc = 80°C$





All multiple inputs and outputs must be shorted together Example: 13/14; 29/30; 22/23 ...

Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

- Non Punch Through (NPT) Fast IGBT
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 50 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
 - Symmetrical design
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive T_C of V_{CEsat}
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS compliant

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V_{CES}	Collector - Emitter Breakdown Voltage		1200	V
Ţ	Continuous Collector Current	$T_C = 25^{\circ}C$	40	
I_{C}	Continuous Conector Current	$T_C = 80$ °C	25	Α
I_{CM}	Pulsed Collector Current	$T_C = 25$ °C	100	
V_{GE}	Gate – Emitter Voltage		±20	V
P_{D}	Maximum Power Dissipation	$T_C = 25^{\circ}C$	208	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125$ °C	50A@1150V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

1 - 7



All ratings @ $T_j = 25$ °C unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
1	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_j = 25$ °C			250	μA
I_{CES}	Zero Gate Voltage Collector Current	$V_{CE} = 1200V$	$T_j = 125$ °C			500	μΑ
V	Collector Emitter saturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C	2.5	3.2	3.7	V
$V_{CE(sat)}$	Conector Emitter saturation voltage	$I_C = 25A$	$T_j = 125$ °C		4.0		V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 1 \text{mA}$		4		6	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			1650		
C_{oes}	Output Capacitance	$V_{CE} = 25V$			250		pF
C_{res}	Reverse Transfer Capacitance	f = 1MHz			110		
Q_g	Total gate Charge	$V_{GE} = 15V$			160		
Q_{ge}	Gate – Emitter Charge	$V_{\text{Bus}} = 600\text{V}$			10		nC
Q_{gc}	Gate – Collector Charge	$I_C = 25A$			70		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switch	ning (25°C)		60		
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 25A$			305		ns
T_{f}	Fall Time	$R_G = 22\Omega$			30		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)			60		
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 25A$			346		ns
$T_{\rm f}$	Fall Time	$R_G = 22\Omega$			40		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 600V$	$T_j = 125$ °C		3.5		I
E_{off}	Turn-off Switching Energy	$I_C = 25A$ $R_G = 22\Omega$	$T_j = 125$ °C		1.5		mJ

Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Payaraa Laakaaa Cumunt	V _R =1200V	$T_j = 25^{\circ}C$			100	۸
1 _{RM}	Maximum Reverse Leakage Current	V _R -1200 V	$T_j = 125$ °C			250	μA
I_F	Forward Current		$Tc = 80^{\circ}C$		25		A
$V_{\rm F}$	V_F Diode Forward Voltage $ I_F = 25A $ $V_{GE} = 0V $	$T_i = 25^{\circ}C$		2.1		V	
V F	Diode Forward Voltage	$V_{GE} = 0V$	$T_{i} = 125^{\circ}C$		1.9		, v
+	Reverse Recovery Time	$I_F = 25A$ $V_R = 600V$ $di/dt = 1000A/\mu s$	$T_j = 25$ °C		95		ns
t _{rr}	Reverse Recovery Time		$T_j = 125$ °C		190		113
Q _{rr}	Reverse Recovery Charge		$T_j = 25$ °C		2.1		μС
Qrr	$di/dt = 1000A/\mu s$		$T_{j} = 125^{\circ}C$		4.5		μ
E_{r}	Reverse Recovery Energy		$T_j = 25$ °C		0.75		mJ
L			$T_{j} = 125^{\circ}C$		1.5		1113



 $Temperature\ sensor\ NTC\ (\text{see application note APT0406 on www.microsemi.com for more information}).$

Symbol	Characteristic	Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_{T} = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$

$$R_{T}: \text{ Thermistor value at T}$$

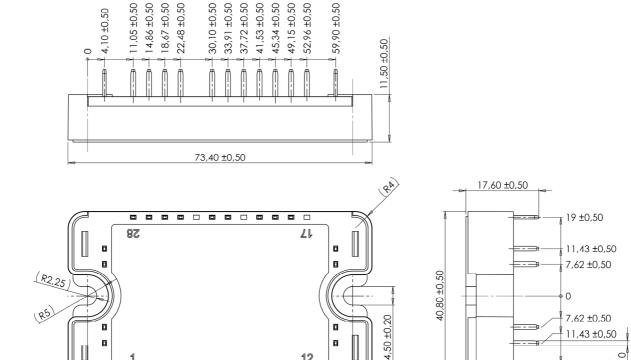
Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
R_{thJC}	Junction to Case Thermal Resistance		IGBT			0.6	°C/W
TthJC			Diode			1.2	C/ W
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T_{J}	Operating junction temperature range		-40		150		
T_{STG}	Storage Temperature Range		-40		125	°C	
$T_{\rm C}$	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight				110	g	

SP3 Package outline (dimensions in mm)

0

64 ±0,20



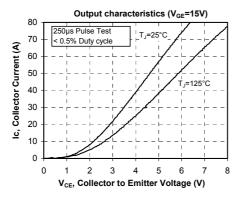
See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

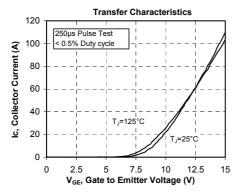
2,50 ±0,20

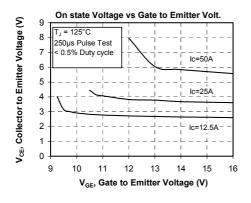
0,80 ±0,10

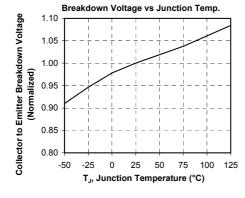


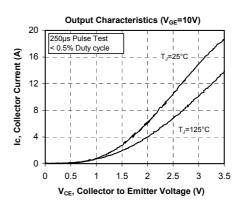
Typical Performance Curve

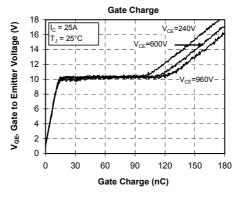


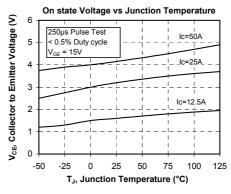


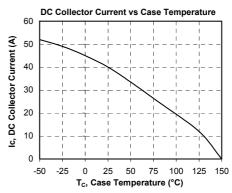




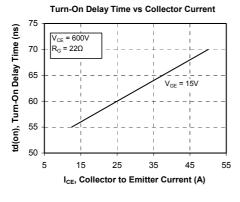


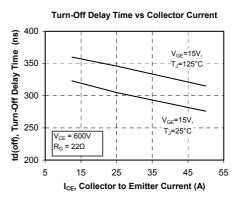


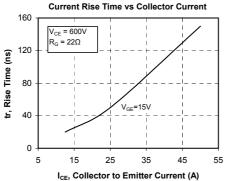


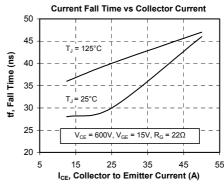


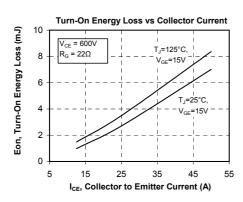


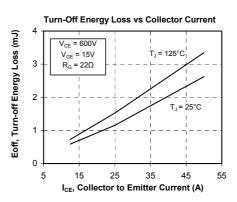


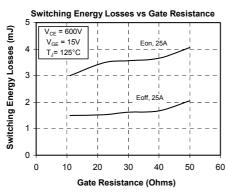


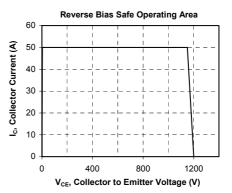




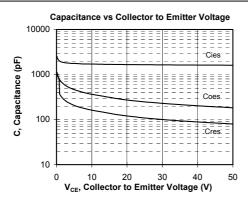


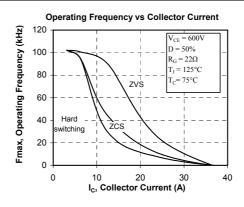


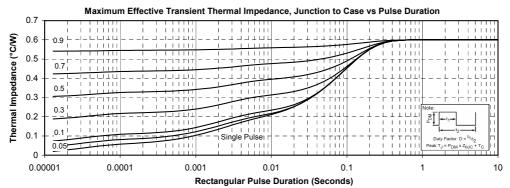














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